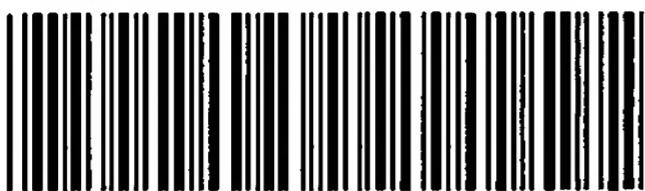


Search Notes



Application/Control No.

10/631 990

Examiner

Khai M. Nguyen

**Applicant(s)/Patent under
Reexamination**

KLEIN ET AL.

Art Unit

2617

SEARCHED

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)